

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BUENZ ET AL.	
		Examiner Hae M Hyeon	Art Unit 2839	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,291,895	12-1966	DYKE PETER F VAN	174/88C
	B	US-5,518,420	05-1996	Pitschi, Franz X.	439/578
	C	US-5,795,188	08-1998	Harwath, Frank A.	439/583
	D	US-6,267,621	07-2001	Pitschi et al.	439/584
	E	US-6,386,915	05-2002	Nelson, James	439/584
	F	US-6,431,911	08-2002	Pitschi, Franz	439/583
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.